

英飞凌 TRENCHSTOP™ 5 软开关 IGBT

英飞凌 TRENCHSTOP™ 5 高速软开关 IGBT

与全电流 RAPID 1 快速、软的反并联二极管共同封装

特征和优点：

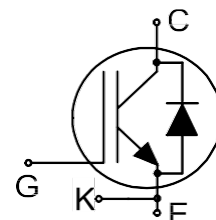
高速 S5 技术提供：

- 高速平滑开关器件适用于硬开关和软开关应用
- 极低 V_{CEsat} ，标称额定电流时为 1.42V
- 即插即用，替代上一代 IGBT
- 650 V 击穿电压
- 低栅极电荷 Q_g
- IGBT 与全电流 RAPID 1 快速反并联二极管共同封装
- 最高结温 175°C
- 符合 JEDEC 目标应用要求
- 无铅镀层；符合 RoHS 标准
- 完整的产品系列和 PSpice 模型：

<http://www.infineon.com/igbt/>

应用：

- 工业级不间断电源 (UPS)
- 工业开关电源
- 储能
- 充电器
- 焊接



产品验证

根据 JEDEC20/22 相关测试的测试条件，符合上述应用要求

封装引脚定义：

- 引脚 C & 背面 - 集电极
- 引脚 E - 发射极
- 引脚 K - 开尔文发射极
- 引脚 G - 栅极

请注意：发射器和开尔文发射器引脚不可互换。它们的交换可能会导致故障。



关键性能和封装参数

Type	V_{CE}	I_C	$V_{CEsat}, T_{vj}=25^{\circ}C$	T_{vjmax}	Marking	Package
IKZ75N65ES5	650V	75A	1.42V	175°C	K75EES5	PG-TO247-4

本数据手册的原文使用英文撰写。为方便起见，英飞凌提供了译文；由于翻译过程中可能使用了自动化工具，英飞凌不保证译文的准确性。为确认准确性，请务必访问 infineon.com 参考最新的英文版本（控制文档）。

TRENCHSTOP™ 5软开关IGBT

目录

描述.....1

目录 2

最大额定值..... 3

热阻抗..... 3

电气特性..... 4

电气特性图 7

封装图编号..... 13

测试条件..... 14

修订记录..... 15

免责声明..... 16

TRENCHSTOP™ 5 软开关 IGBT

最大额定值

注意：为了获得最佳的使用寿命和可靠性，英飞凌建议运行条件不超过本数据手册中所述最大额定值的 80%。

Parameter	Symbol	Value	Unit
Collector-emitter voltage, $T_{vj} \geq 25^{\circ}\text{C}$	V_{CE}	650	V
DC collector current, limited by T_{vjmax} ¹⁾	I_C	80.0	A
$T_c = 25^{\circ}\text{C}$ value limited by bondwire $T_c = 100^{\circ}\text{C}$		80.0	
Pulsed collector current, t_p limited by T_{vjmax}	I_{Cpuls}	300.0	A
Turn off safe operating area $V_{CE} \leq 650\text{V}$, $T_{vj} \leq 175^{\circ}\text{C}$, $t_p = 1\mu\text{s}$	-	300.0	A
Diode forward current, limited by T_{vjmax} ¹⁾	I_F	80.0	A
$T_c = 25^{\circ}\text{C}$ value limited by bondwire $T_c = 100^{\circ}\text{C}$		80.0	
Diode pulsed current, t_p limited by T_{vjmax}	I_{Fpuls}	300.0	A
Gate-emitter voltage Transient Gate-emitter voltage ($t_p \leq 10\mu\text{s}$, $D < 0.010$)	V_{GE}	± 20 ± 30	V
Power dissipation $T_c = 25^{\circ}\text{C}$ Power dissipation $T_c = 100^{\circ}\text{C}$	P_{tot}	395.0 197.0	W
Operating junction temperature	T_{vj}	-40...+175	$^{\circ}\text{C}$
Storage temperature	T_{stg}	-55...+150	$^{\circ}\text{C}$
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s		260	$^{\circ}\text{C}$
Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm

热阻抗

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	

 R_{th} 特性

IGBT thermal resistance, junction - case	$R_{th(j-c)}$		-	-	0.38	K/W
Diode thermal resistance, junction - case	$R_{th(j-c)}$		-	-	0.46	K/W
Thermal resistance junction - ambient	$R_{th(j-a)}$		-	-	40	K/W

¹⁾ 价值受键合线限制

TRENCHSTOP™ 5 软开关 IGBT

电气特性，测于 $T_{vj} = 25^{\circ}\text{C}$ 的条件下，除非另有规定

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
静态特性						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0V, I_C = 0.20mA$	650	-	-	V
Collector-emitter saturation voltage	V_{CESat}	$V_{GE} = 15.0V, I_C = 75.0A$ $T_{vj} = 25^{\circ}C$ T_{vj} $= 125^{\circ}C$ $T_{vj} =$ $175^{\circ}C$	- - -	1.42 1.55 1.65	1.75 - -	V
Diode forward voltage	V_F	$V_{GE} = 0V, I_F = 75.0A$ $T_{vj} = 25^{\circ}C$ T_{vj} $= 125^{\circ}C$ $T_{vj} =$ $175^{\circ}C$	- - -	1.50 1.48 1.45	1.75 - -	V
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_C = 0.75mA, V_{CE} = V_{GE}$	3.2	4.0	4.8	V
Zero gate voltage collector current	I_{CES}	$V_{CE} = 650V, V_{GE} = 0V$ $T_{vj} = 25^{\circ}C$ $T_{vj} = 175^{\circ}C$	- -	- 3000	50 -	μA
Gate-emitter leakage current	I_{GES}	$V_{CE} = 0V, V_{GE} = 20V$	-	-	100	nA
Transconductance	g_{fs}	$V_{CE} = 20V, I_C = 75.0A$	-	100.0	-	S

电气特性，测于 $T_{vj} = 25^{\circ}\text{C}$ 的条件下，除非另有规定

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
动态特性						
Input capacitance	C_{ies}	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$	-	4500	-	pF
Output capacitance	C_{oes}		-	130	-	
Reverse transfer capacitance	C_{res}		-	17	-	
Gate charge	Q_G	$V_{CC} = 520V, I_C = 75.0A,$ $V_{GE} = 15V$	-	164.0	-	nC
Internal emitter inductance measured 5mm (0.197 in.) from case	L_E		-	13.0	-	nH

开关特性、感性负载

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	

IGBT 特性，测于 $T_{vj} = 25^{\circ}\text{C}$ 的条件下

Turn-on delay time	$t_{d(on)}$	$T_{vj} = 25^{\circ}\text{C},$ $V_{CC} = 400\text{V}, I_C = 75.0\text{A},$ $V_{GE} = 0.0/15.0\text{V},$ $R_{G(on)} = 22.3\Omega, R_{G(off)} = 22.3\Omega,$ $L\sigma = 30\text{nH}, C\sigma = 30\text{pF}$ $L\sigma, C\sigma$ from Fig. E Energy losses include "tail" and diode reverse recovery.	-	46	-	ns
Rise time	t_r		-	25	-	ns
Turn-off delay time	$t_{d(off)}$		-	405	-	ns
Fall time	t_f		-	22	-	ns
Turn-on energy	E_{on}		-	1.30	-	mJ
Turn-off energy	E_{off}		-	1.50	-	mJ
Total switching energy	E_{ts}		-	2.80	-	mJ

TRENCHSTOP™ 5 软开关 IGBT

Turn-on delay time	$t_{d(on)}$	$T_{vj} = 25^{\circ}\text{C}$, $V_{CC} = 400\text{V}$, $I_C = 37.5\text{A}$, $V_{GE} = 0.0/15.0\text{V}$, $R_{G(on)} = 22.3\Omega$, $R_{G(off)} = 22.3\Omega$, $L\sigma = 30\text{nH}$, $C\sigma = 30\text{pF}$ $L\sigma$, $C\sigma$ from Fig. E Energy losses include “tail” and diode reverse recovery.	-	43	-	ns
Rise time	t_r		-	17	-	ns
Turn-off delay time	$t_{d(off)}$		-	430	-	ns
Fall time	t_f		-	19	-	ns
Turn-on energy	E_{on}		-	0.60	-	mJ
Turn-off energy	E_{off}		-	0.50	-	mJ
Total switching energy	E_{ts}		-	1.10	-	mJ

二极管特性, $T_{vj} = 25^{\circ}\text{C}$

Diode reverse recovery time	t_{rr}	$T_{vj} = 25^{\circ}\text{C}$, $V_R = 400\text{V}$, I_F $= 75.0\text{A}$, $di_F/dt = 2500\text{A}/\mu\text{s}$	-	72	-	ns
Diode reverse recovery charge	Q_{rr}		-	1.40	-	μC
Diode peak reverse recovery current	I_{rm}		-	39.0	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-700	-	A/ μs
Diode reverse recovery time	t_{rr}	$T_{vj} = 25^{\circ}\text{C}$, $V_R = 400\text{V}$, I_F $= 37.5\text{A}$, $di_F/dt = 2500\text{A}/\mu\text{s}$	-	47	-	ns
Diode reverse recovery charge	Q_{rr}		-	1.00	-	μC
Diode peak reverse recovery current	I_{rm}		-	36.0	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-1300	-	A/ μs

开关特性、感性负载

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	

IGBT 特性, $T_{vj} = 150^{\circ}\text{C}$

Turn-on delay time	$t_{d(on)}$	$T_{vj} = 150^{\circ}\text{C}$, $V_{CC} = 400\text{V}$, $I_C = 75.0\text{A}$, $V_{GE} = 0.0/15.0\text{V}$, $R_{G(on)} = 22.3\Omega$, $R_{G(off)} = 22.3\Omega$, $L\sigma = 30\text{nH}$, $C\sigma = 30\text{pF}$ $L\sigma$, $C\sigma$ from Fig. E Energy losses include “tail” and diode reverse recovery.	-	42	-	ns
Rise time	t_r		-	28	-	ns
Turn-off delay time	$t_{d(off)}$		-	450	-	ns
Fall time	t_f		-	25	-	ns
Turn-on energy	E_{on}		-	1.70	-	mJ
Turn-off energy	E_{off}		-	1.90	-	mJ
Total switching energy	E_{ts}		-	3.60	-	mJ
Turn-on delay time	$t_{d(on)}$	$T_{vj} = 150^{\circ}\text{C}$, $V_{CC} = 400\text{V}$, $I_C = 37.5\text{A}$, $V_{GE} = 0.0/15.0\text{V}$, $R_{G(on)} = 22.3\Omega$, $R_{G(off)} = 22.3\Omega$, $L\sigma = 30\text{nH}$, $C\sigma = 30\text{pF}$ $L\sigma$, $C\sigma$ from Fig. E Energy losses include “tail” and diode reverse recovery.	-	38	-	ns
Rise time	t_r		-	18	-	ns
Turn-off delay time	$t_{d(off)}$		-	480	-	ns
Fall time	t_f		-	36	-	ns
Turn-on energy	E_{on}		-	1.00	-	mJ
Turn-off energy	E_{off}		-	0.70	-	mJ
Total switching energy	E_{ts}		-	1.70	-	mJ

TRENCHSTOP™ 5 软开关 IGBT

二极管特性, $T_{vj} = 150^{\circ}\text{C}$

Diode reverse recovery time	t_{rr}	$T_{vj} = 150^{\circ}\text{C}, V_R$ $= 400\text{V}, I_F =$ $75.0\text{A},$ $di_F/dt = 2500\text{A}/\mu\text{s}$	-	115	-	ns
Diode reverse recovery charge	Q_{rr}		-	4.00	-	μC
Diode peak reverse recovery current	I_{rrm}		-	64.0	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-800	-	$\text{A}/\mu\text{s}$
Diode reverse recovery time	t_{rr}	$T_{vj} = 150^{\circ}\text{C}, V_R$ $= 400\text{V}, I_F =$ $37.5\text{A},$ $di_F/dt = 2500\text{A}/\mu\text{s}$	-	85	-	ns
Diode reverse recovery charge	Q_{rr}		-	2.80	-	μC
Diode peak reverse recovery current	I_{rrm}		-	60.0	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-1100	-	$\text{A}/\mu\text{s}$

TRENCHSTOP™ 5 软开关 IGBT

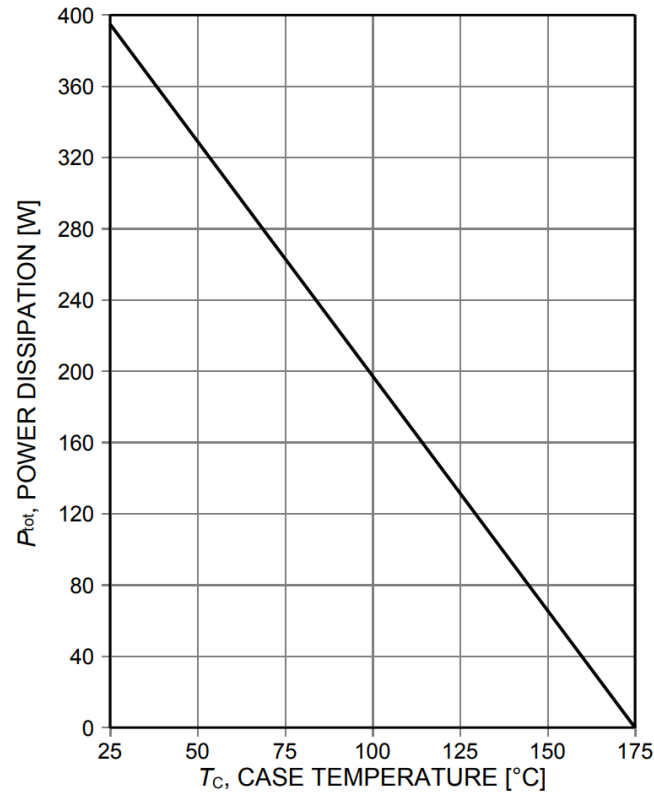


Figure 1. Power dissipation as a function of case temperature ($T_{vj} \leq 175^\circ\text{C}$)

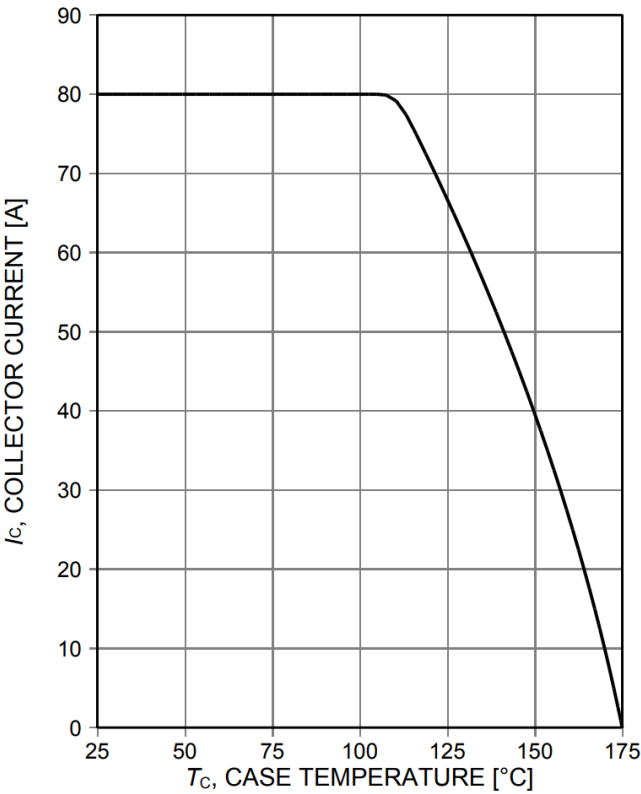


Figure 2. Collector current as a function of case temperature ($V_{GE} \geq 15\text{V}$, $T_{vj} \leq 175^\circ\text{C}$)

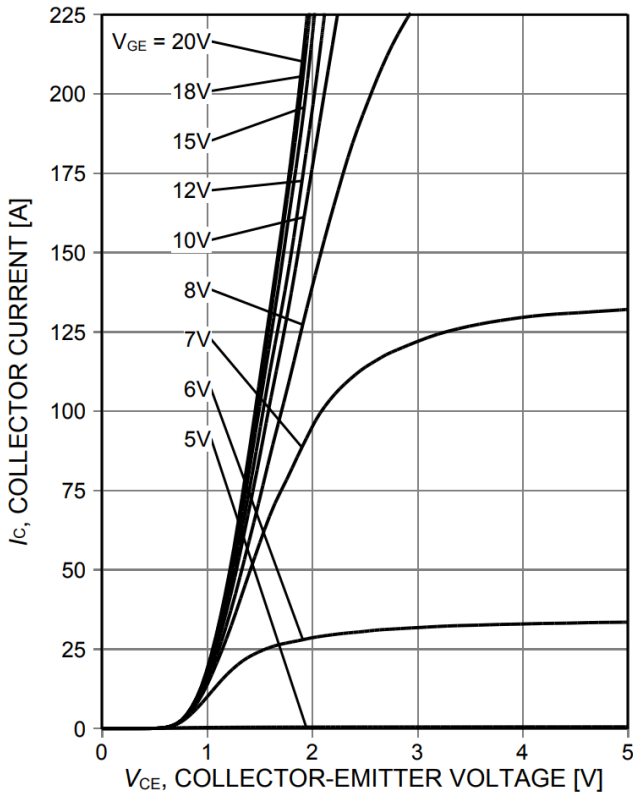


Figure 3. Typical output characteristic ($T_{vj} = 25^\circ\text{C}$)

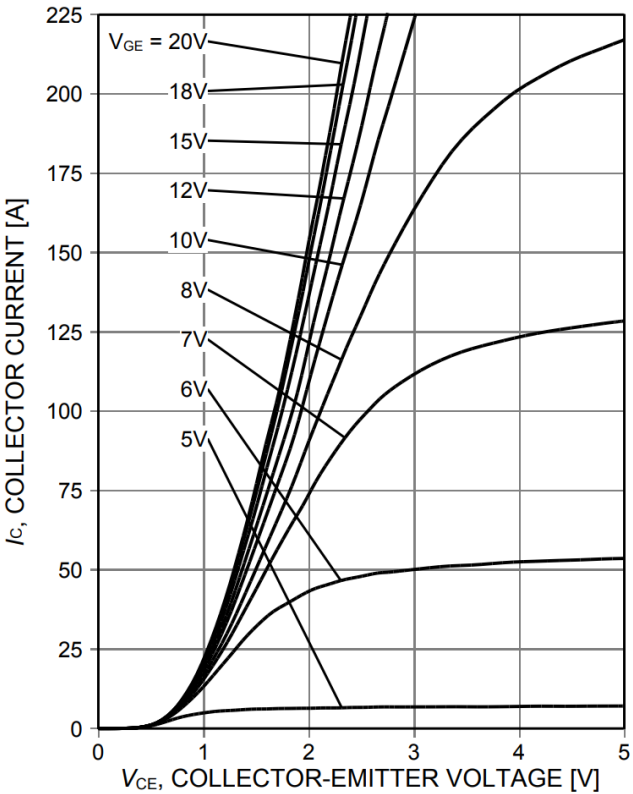


Figure 4. Typical output characteristic ($T_{vj} = 175^\circ\text{C}$)

TRENCHSTOP™ 5软开关IGBT

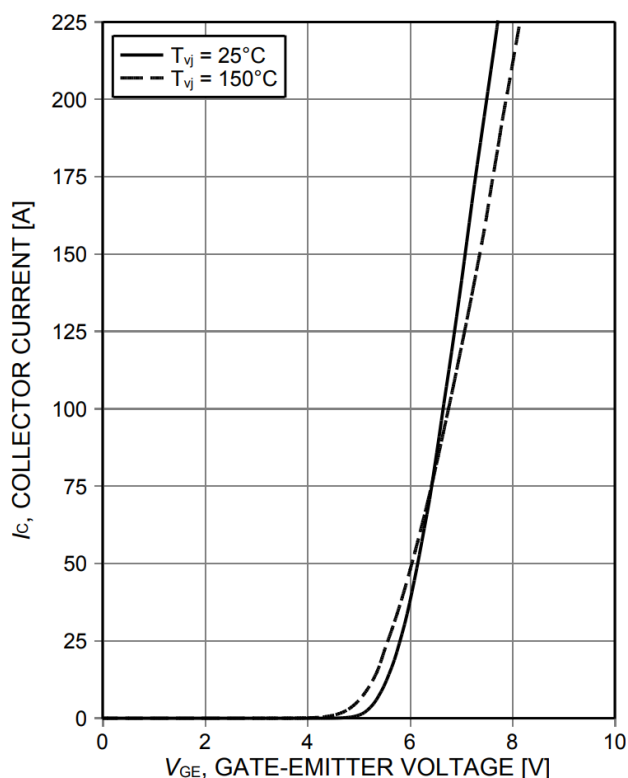


Figure 5. **Typical transfer characteristic**
($V_{CE}=20V$)

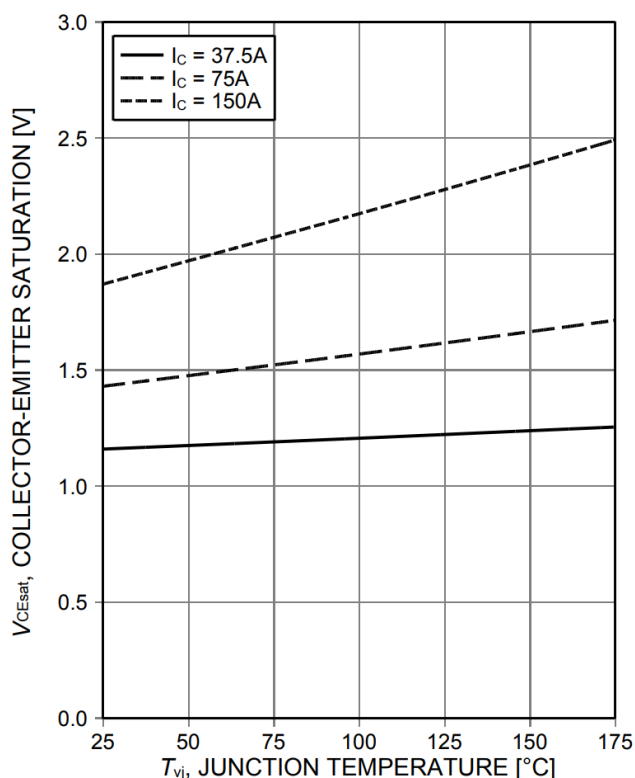


Figure 6. **Typical collector-emitter saturation voltage as a function of junction temperature**
($V_{GE}=15V$)

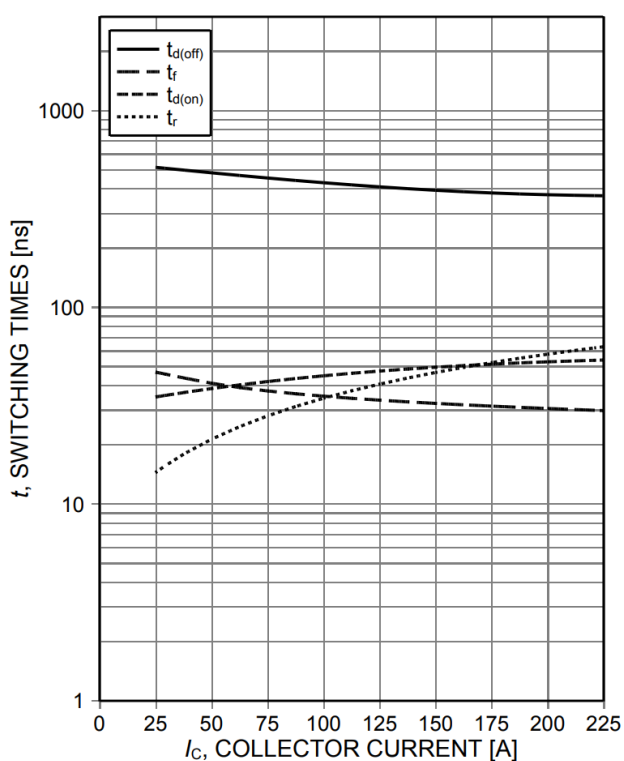


Figure 7. **Typical switching times as a function of collector current**
(inductive load, $T_{vj}=150^{\circ}C$, $V_{CE}=400V$, $V_{GE}=0/15V$, $R_{Gon}=22,3\Omega$, $R_{Goff}=22,3\Omega$, dynamic test circuit in Figure E)

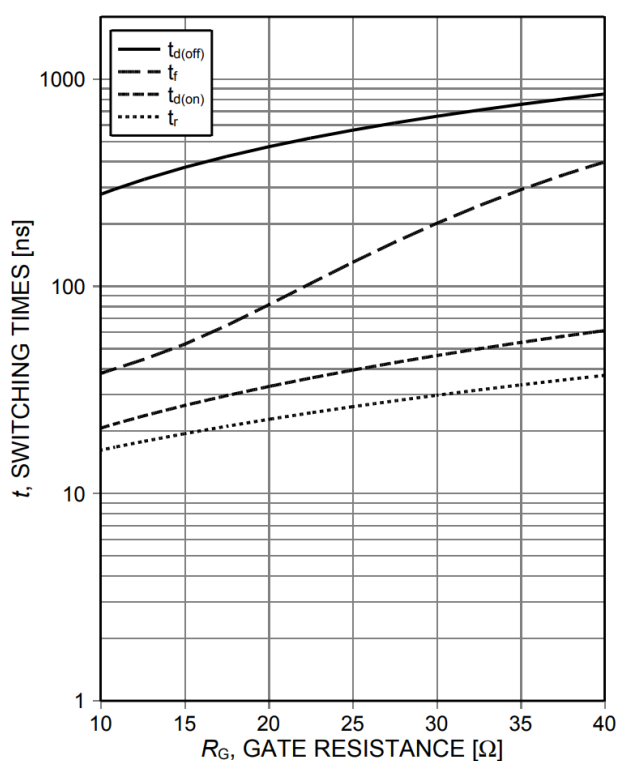


Figure 8. **Typical switching times as a function of gate resistance**
(inductive load, $T_{vj}=150^{\circ}C$, $V_{CE}=400V$, $V_{GE}=0/15V$, $I_C=75A$, dynamic test circuit in Figure E)

TRENCHSTOP™ 5 软开关 IGBT

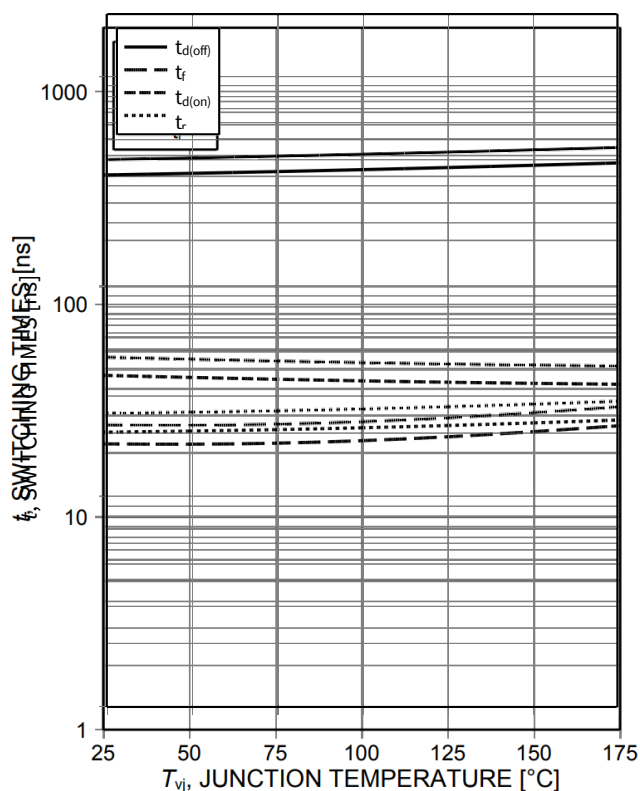


Figure 9. **Typical switching times as a function of junction temperature**
(inductive load, $V_{CE}=400V$, $V_{GE}=0/15V$, $I_C=75A$, $R_{Gon}=22,3\Omega$, $R_{Goff}=22,3\Omega$, dynamic test circuit in Figure E)

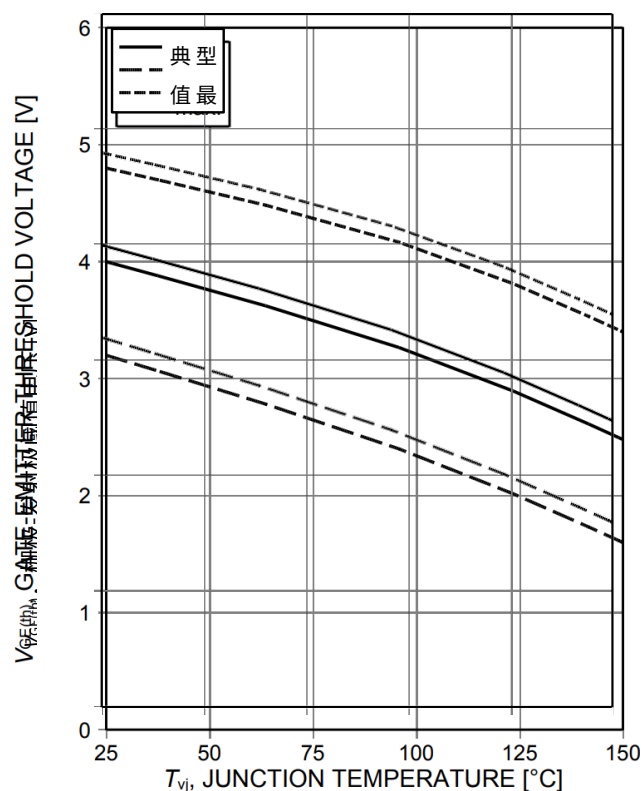


Figure 10. **Gate-emitter threshold voltage as a function of junction temperature**
($I_C=0.75mA$)

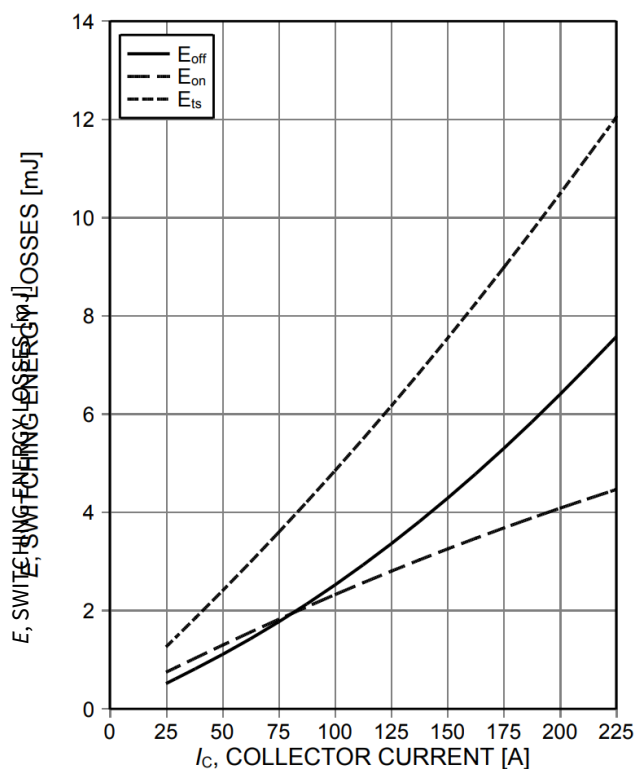


Figure 11. **Typical switching energy losses as a function of collector current**
(inductive load, $T_{vj}=150^\circ C$, $V_{CE}=400V$, $V_{GE}=0/15V$, $R_{Gon}=22,3\Omega$, $R_{Goff}=22,3\Omega$, dynamic test circuit in Figure E)

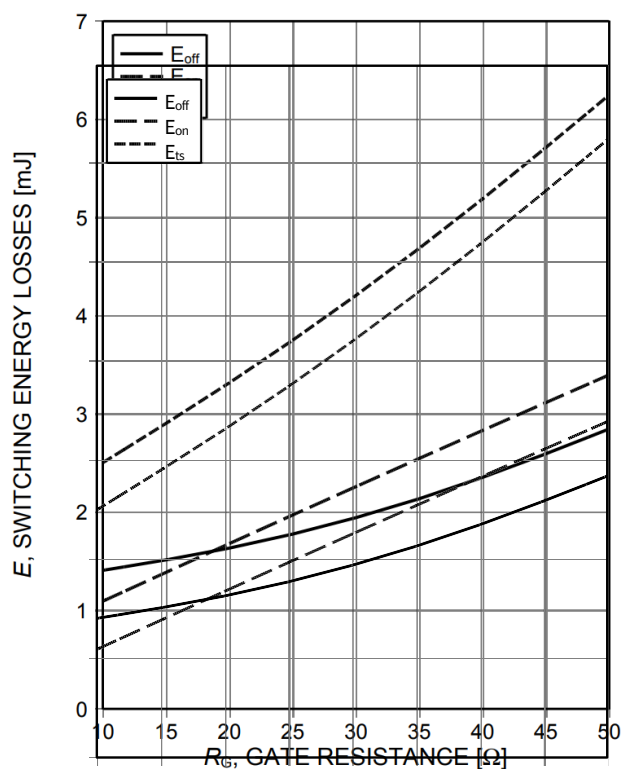


Figure 12. **Typical switching energy losses as a function of gate resistance**
(inductive load, $T_{vj}=150^\circ C$, $V_{CE}=400V$, $V_{GE}=0/15V$, $I_C=75A$, dynamic test circuit in Figure E)

TRENCHSTOP™ 5 软开关 IGBT

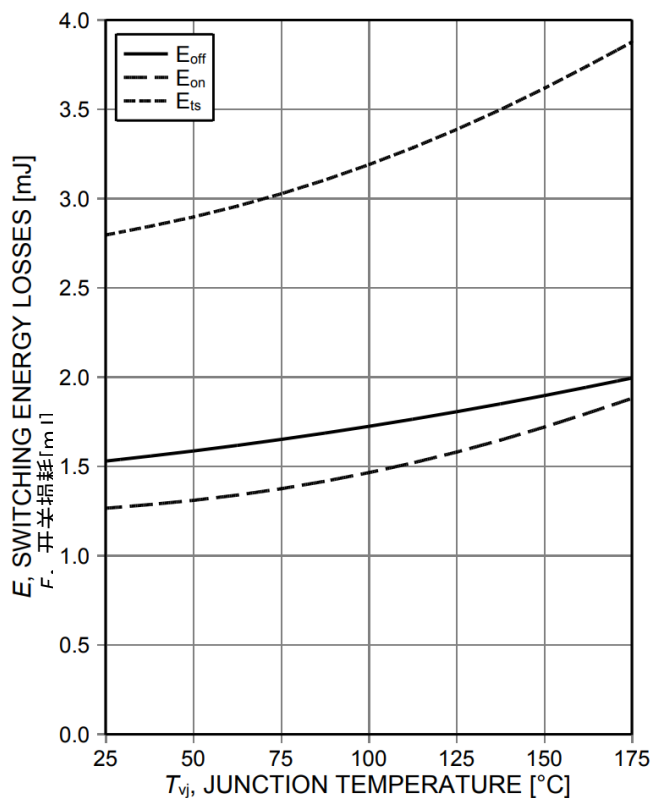


Figure 13. **Typical switching energy losses as a function of junction temperature**
(inductive load, $V_{CE}=400V$, $V_{GE}=0/15V$, $I_C=75A$, $R_{Gon}=22,3\Omega$, $R_{Goff}=22,3\Omega$, dynamic test circuit in Figure E)

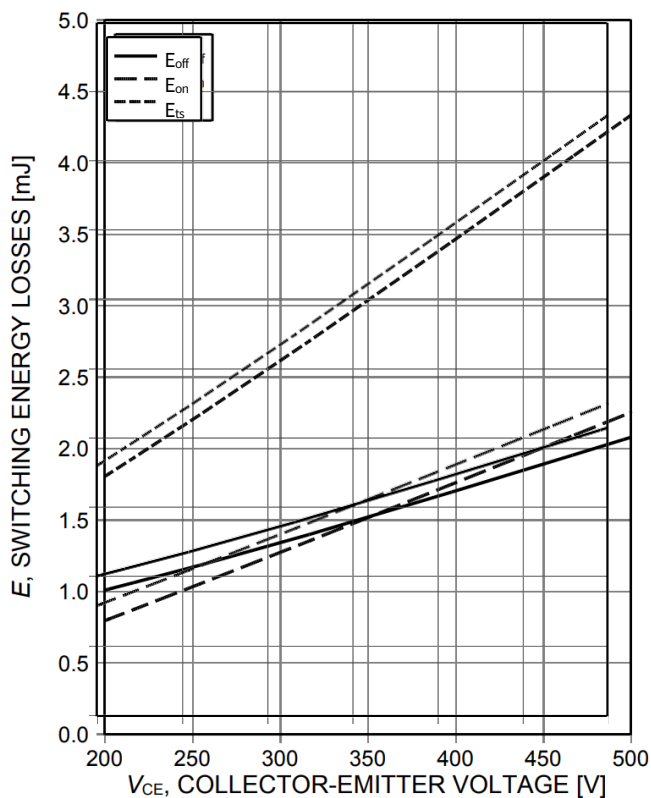


Figure 14. **Typical switching energy losses as a function of collector emitter voltage**
(inductive load, $T_{vj}=150^\circ C$, $V_{GE}=0/15V$, $I_C=75A$, $R_{Gon}=22,3\Omega$, $R_{Goff}=22,3\Omega$, dynamic test circuit in Figure E)

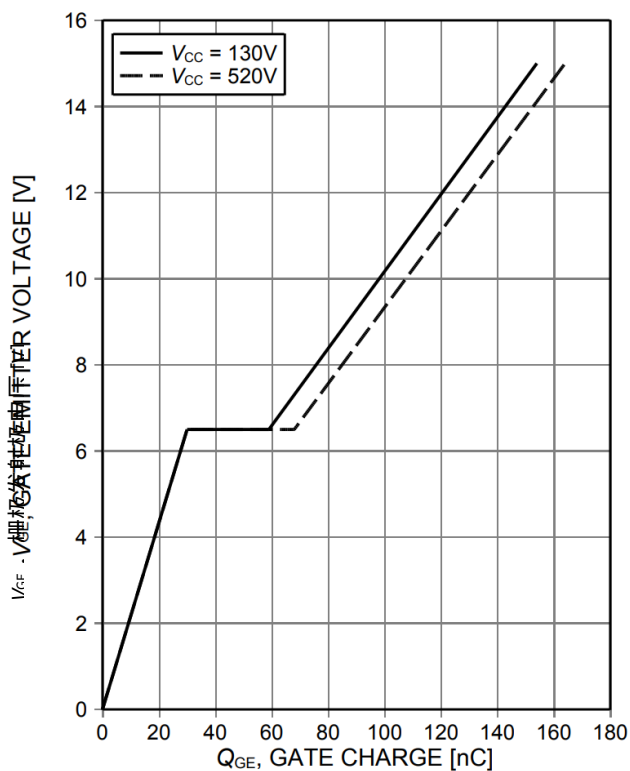


Figure 15. **Typical gate charge**
($I_C=75A$)

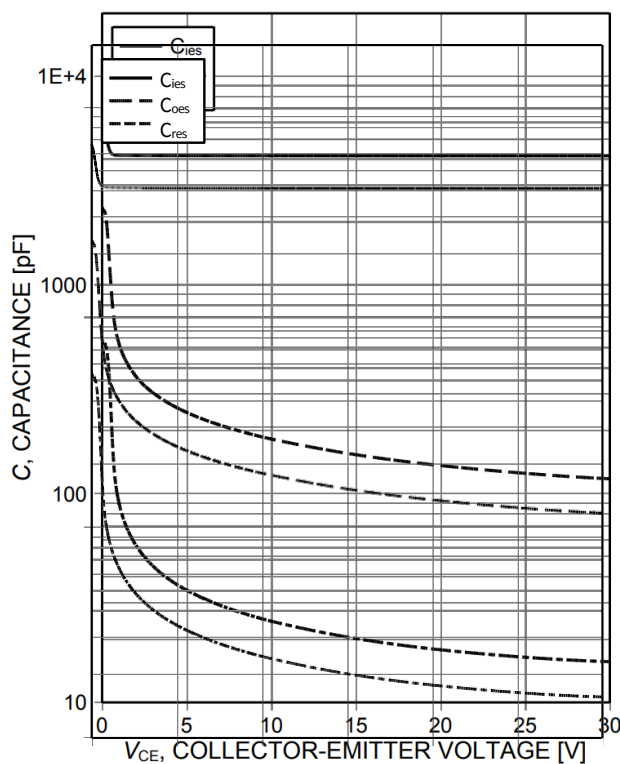
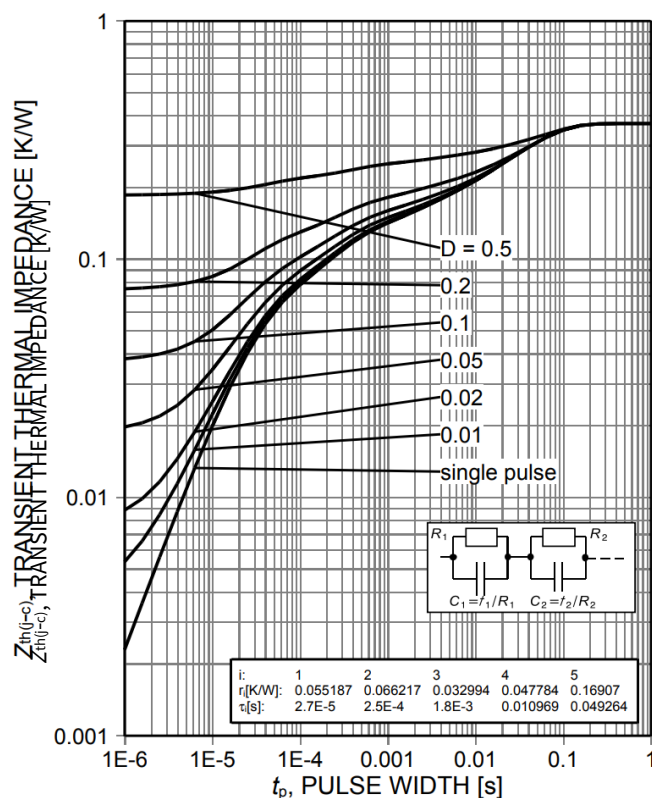
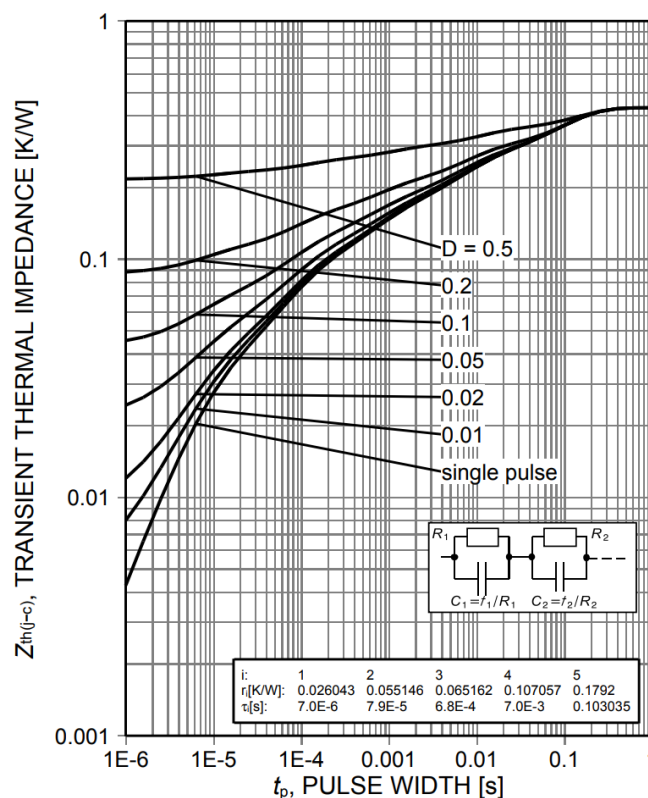
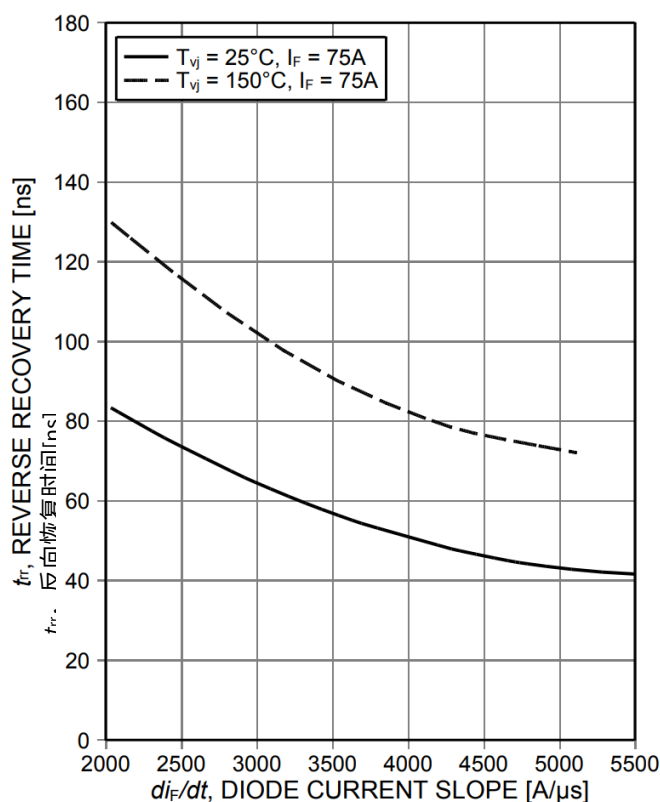
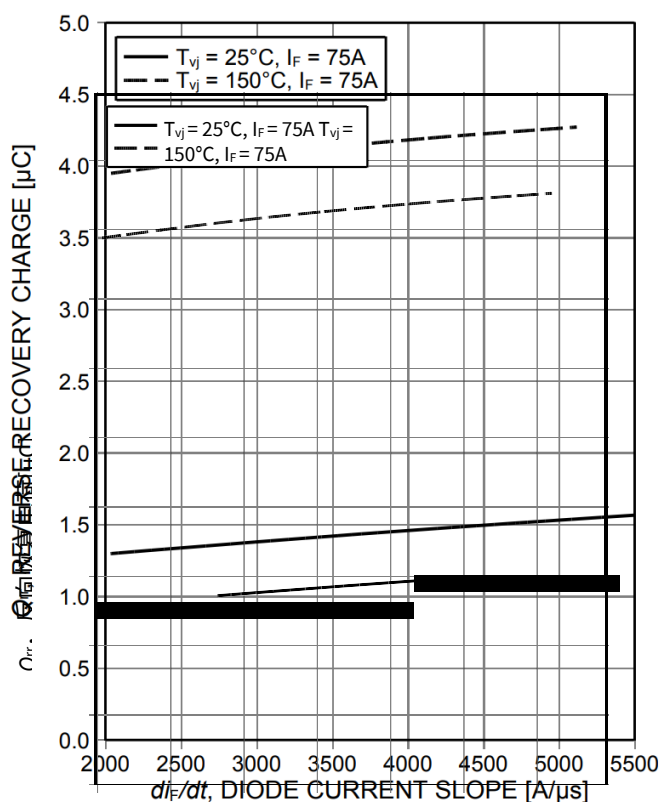


Figure 16. **Typical capacitance as a function of collector-emitter voltage**
($V_{GE}=0V$, $f=1MHz$)

TRENCHSTOP™5 软开关 IGBT

Figure 17. IGBT transient thermal impedance ($D=t_p/T$)Figure 18. Diode transient thermal impedance as a function of pulse width ($D=t_p/T$)Figure 19. Typical reverse recovery time as a function of diode current slope ($V_R=400V$)Figure 20. Typical reverse recovery charge as a function of diode current slope ($V_R=400V$)

TRENCHSTOP™ 5 软开关 IGBT

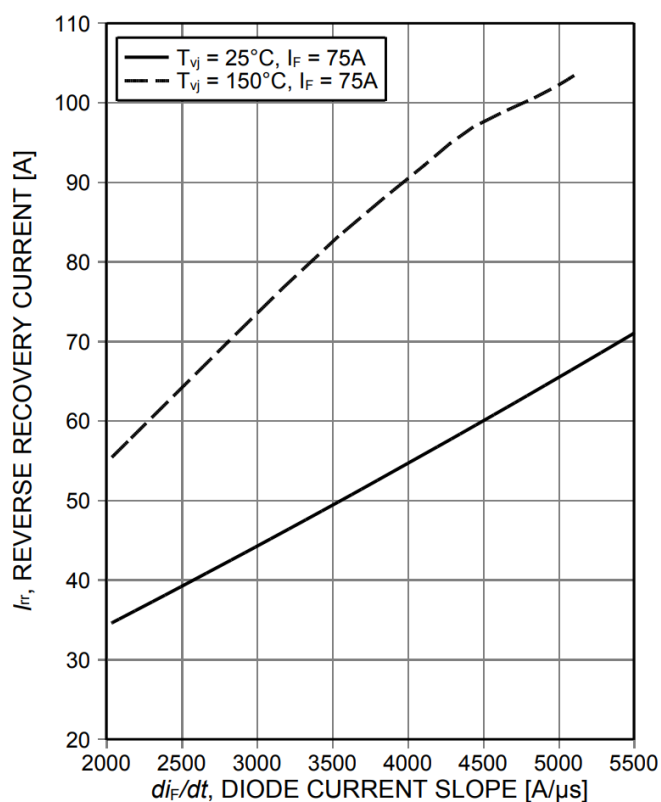


Figure 21. Typical reverse recovery current as a function of diode current slope ($V_R=400V$)

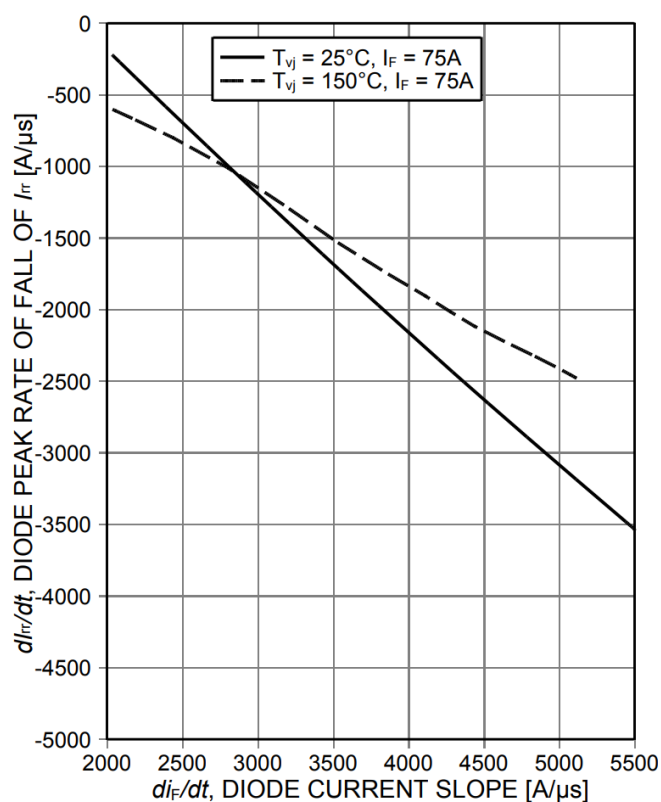


Figure 22. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope ($V_R=400V$)

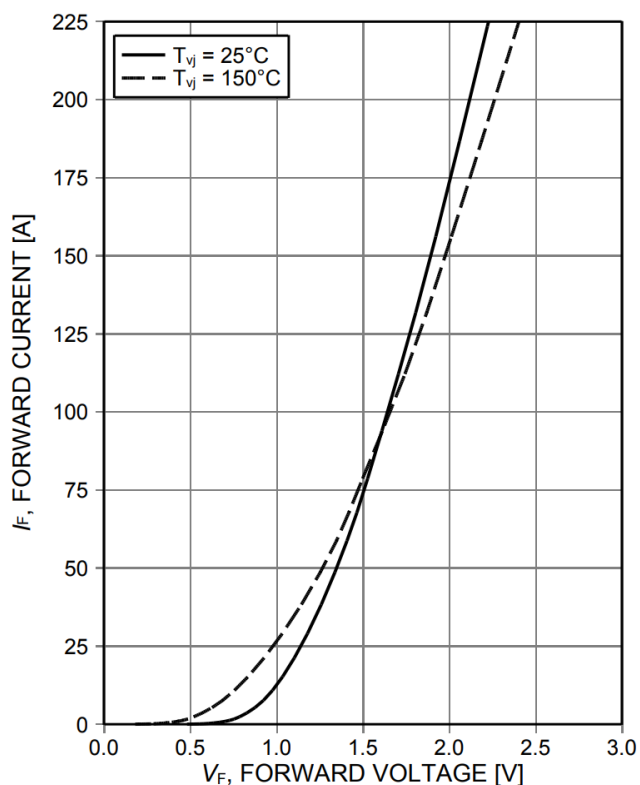


Figure 23. Typical diode forward current as a function of forward voltage

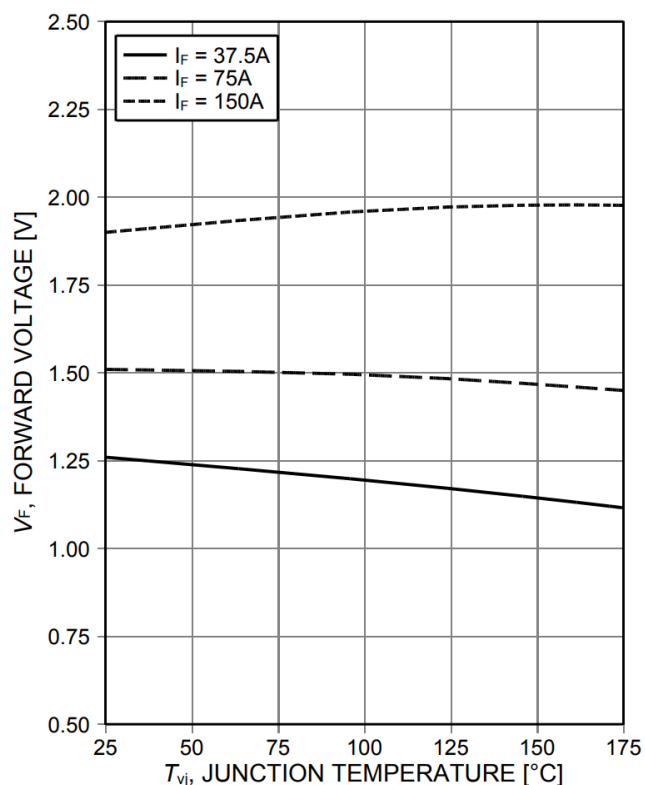
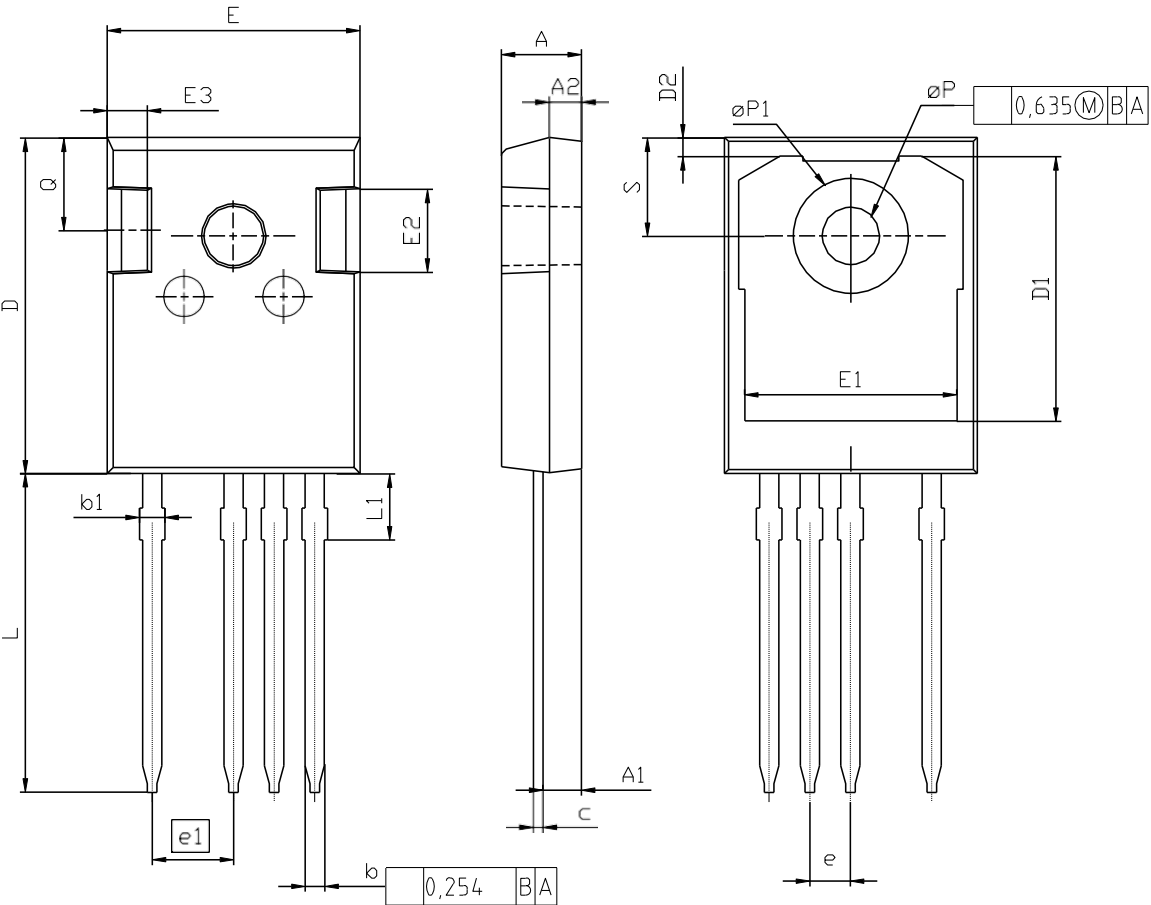


Figure 24. Typical diode forward voltage as a function of junction temperature

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封装图 PG-TO247-4



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.83	5.21	0.190	0.205
A1	2.29	2.54	0.090	0.100
A2	1.90	2.16	0.075	0.085
b	1.07	1.33	0.042	0.052
b1	1.10	1.70	0.043	0.067
c	0.50	0.70	0.020	0.028
D	20.80	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.95	1.35	0.037	0.053
E	15.70	16.13	0.618	0.635
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.00	2.60	0.039	0.102
e	2.54 (BSC)		0.100 (BSC)	
e1	5.08		0.200	
N	4		4	
L	19.72	20.32	0.776	0.800
L1	4.02	4.40	0.158	0.173
øP	3.50	3.70	0.138	0.146
øP1	7.00	7.40	0.276	0.291
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

DOCUMENT NO.
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SCALE

0 5 5 7.5mm

EUROPEAN PROJECTION

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1

TRENCHSTOP™ 5软开关IGBT

测试条件

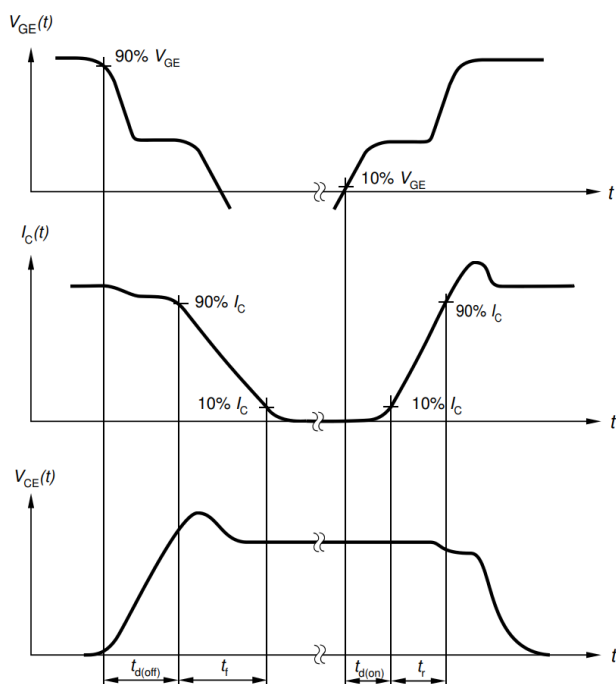


Figure A. Definition of switching times

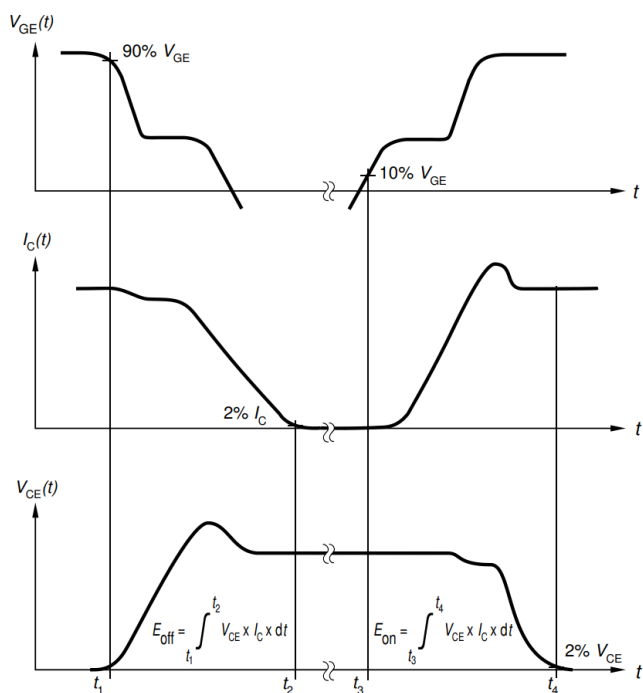


Figure B. Definition of switching losses

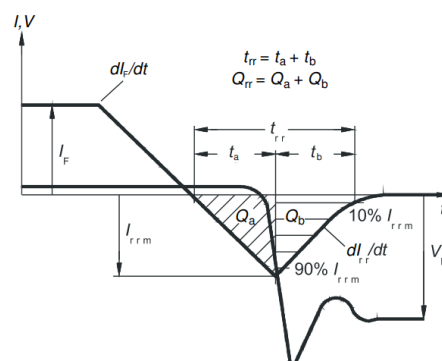


Figure C. Definition of diode switching characteristics

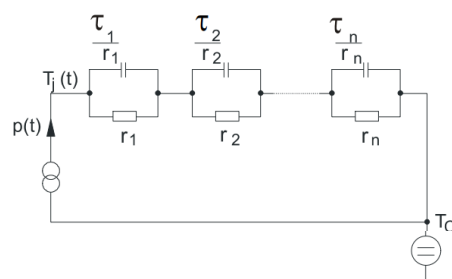


Figure D. Thermal equivalent circuit

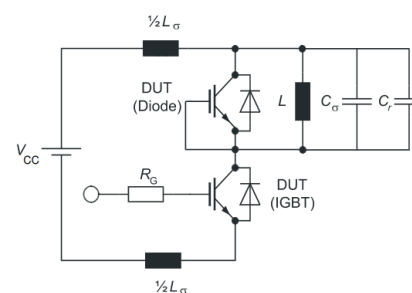


Figure E. **Dynamic test circuit**
 Parasitic inductance L_σ ,
 parasitic capacitor C_σ ,
 relief capacitor C_r ,
 (only for ZVT switching)

TRENCHSTOP™ 5软开关IGBT

修订记录

IKZ75N65ES5

Revision: 2019-06-07, Rev. 2.2

历史修订版本

Revision	Date	Subjects (major changes since last revision)
2.1	2017-04-26	Final data sheet
2.2	2019-06-07	Update Fig.3 and Fig.4



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